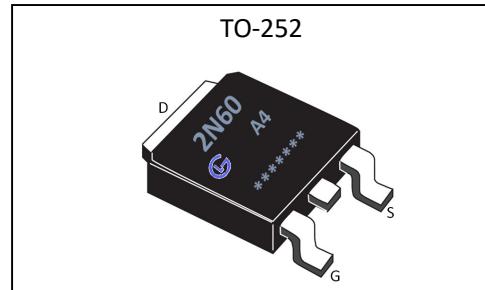


### General Description:

GL2N60A4 the silicon N-channel Enhanced VDMOSFETS, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-252, which accords with the RoHS standard.

$V_{DSS}$	600	V
$I_D$	2	A
$P_D (T_C=25^\circ C)$	35	W
$R_{DS(ON)} \text{ type}$	3.6	$\Omega$



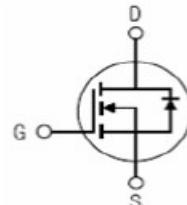
### Features:

- Fast Switching
- Low Gate Charge and  $R_{DS(on)}$
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

### Applications:

Power switch circuit of adaptor and charger.

Inner Equivalent Principium Chart



### Absolute ( $T_c = 25^\circ C$ unless otherwise specified) :

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-to-Source Voltage	600	V
$I_D$	Continuous Drain Current	2.0	A
	Continuous Drain Current $T_c = 100^\circ C$	1.45	A
$I_{DM}^{a1}$	Pulsed Drain Current	8.0	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 30$	V
$E_{AS}^{a2}$	Single Pulse Avalanche Energy	80	mJ
$E_{AR}^{a1}$	Avalanche Energy ,Repetitive	6.4	mJ
$I_{AR}^{a1}$	Avalanche Current	1.1	A
$dv/dt^{a3}$	Peak Diode Recovery $dv/dt$	5.0	V/ns
$P_D$	Power Dissipation	35	W
	Derating Factor above $25^\circ C$	0.28	W/ $^\circ C$
$T_J, T_{stg}$	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ C$
$T_L$	MaximumTemperature for Soldering	300	$^\circ C$



# GL2N60A4

## GL Silicon N-Channel Power MOSFET

**Electrical Characteristics** ( $T_c = 25^\circ\text{C}$  unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	600	--	--	V
$\Delta V_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=250\mu\text{A}$ , Reference $25^\circ\text{C}$	--	0.60	--	$\text{V}/^\circ\text{C}$
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS}=600\text{V}, V_{GS}=0\text{V}, T_a=25^\circ\text{C}$	--	--	1	$\mu\text{A}$
		$V_{DS}=480\text{V}, V_{GS}=0\text{V}, T_a=125^\circ\text{C}$	--	--	250	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+30\text{V}$	--	--	10	$\mu\text{A}$
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-30\text{V}$	--	--	-10	$\mu\text{A}$

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10\text{V}, I_D=1.0\text{A}$	--	3.6	4.3	$\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.0	3.0	4.0	V
Pulse width $t_p \leq 380\mu\text{s}, \delta \leq 2\%$						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$g_{fs}$	Forward Transconductance	$V_{DS}=15\text{V}, I_D=1\text{A}$	--	1.8	--	S
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=25\text{V}$	--	280	--	pF
$C_{oss}$	Output Capacitance	$f=1.0\text{MHz}$	--	31	--	
$C_{rss}$	Reverse Transfer Capacitance		--	5.4	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D=2.0\text{A}, V_{DD}=300\text{V}$	--	7	--	ns
$t_r$	Rise Time		--	5	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	26	--	
$t_f$	Fall Time		--	10.5	--	
$Q_g$	Total Gate Charge	$I_D=2.0\text{A}, V_{DD}=300\text{V}$	--	8.5	--	nC
$Q_{gs}$	Gate to Source Charge		--	1.5	--	
$Q_{gd}$	Gate to Drain ( "Miller" )Charge		--	4.0	--	

**Source-Drain Diode Characteristics**

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I <sub>S</sub>	Continuous Source Current (Body Diode)		--	--	2	A
I <sub>SM</sub>	Maximum Pulsed Current (Body Diode)		--	--	8	A
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =2.0A, V <sub>GS</sub> =0V	--	--	1.5	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> =2.0A, T <sub>j</sub> =25°C	--	405	--	ns
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>F</sub> /dt=100A/us, V <sub>GS</sub> =0V	--	1150	--	nC
Pulse width t <sub>p</sub> ≤380μs, δ≤2%						

Symbol	Parameter	Typ.	Units
R <sub>θJC</sub>	Junction-to-Case	3.57	°C/W
R <sub>θJA</sub>	Junction-to-Ambient	62	°C/W

<sup>a1</sup>: Repetitive rating; pulse width limited by maximum junction temperature

<sup>a2</sup>: L=10.0mH, I<sub>D</sub>=3.7A, Start T<sub>j</sub>=25°C

<sup>a3</sup>: I<sub>SD</sub>=2A, di/dt ≤100A/us, V<sub>DD</sub>≤BV<sub>DS</sub>, Start T<sub>j</sub>=25°C

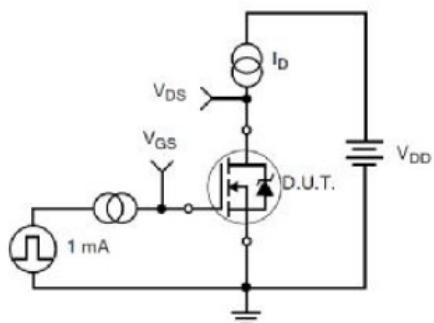
**Test Circuit and Waveform**


Figure 17. Gate Charge Test Circuit

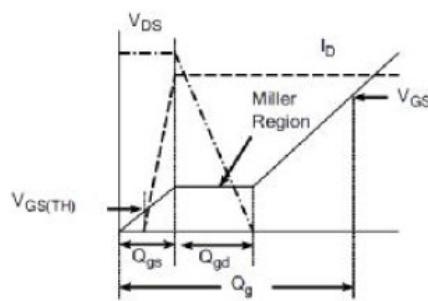


Figure 18. Gate Charge Waveform

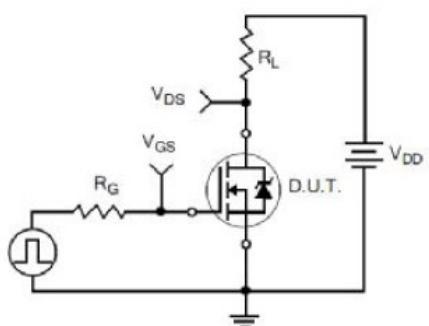


Figure 19. Resistive Switching Test Circuit

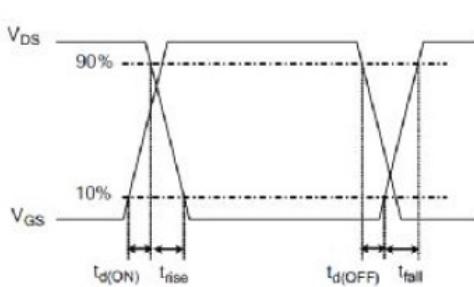


Figure 20. Resistive Switching Waveforms

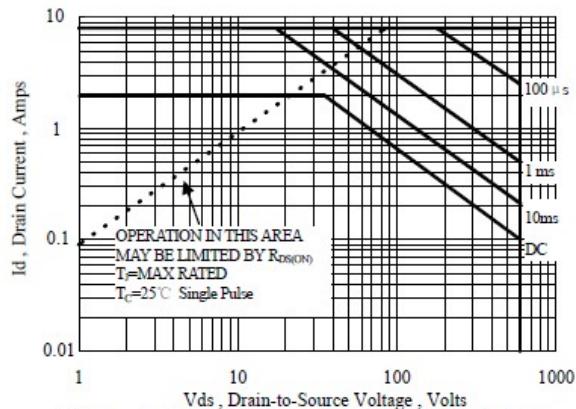
**Characteristics Curve:**


Figure 1 Maximum Forward Bias Safe Operating Area

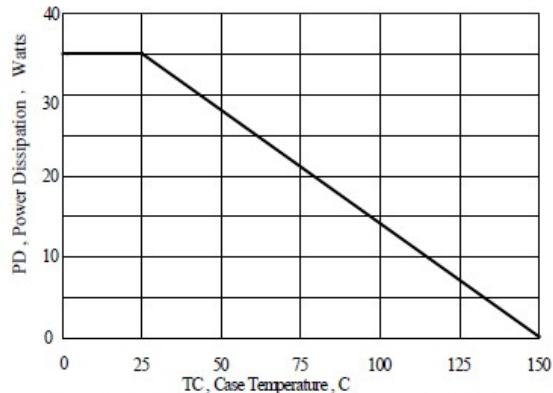


Figure 2 Maximum Power Dissipation vs Case Temperature

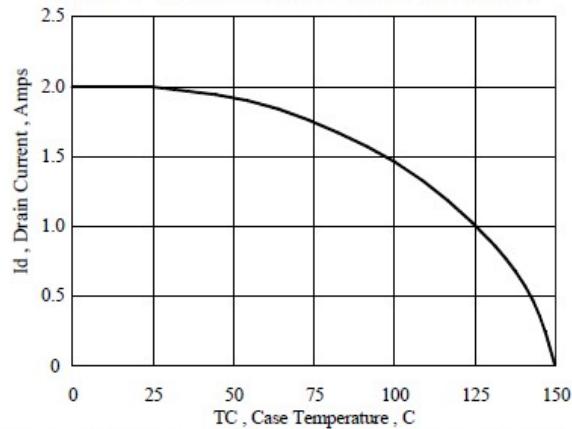


Figure 3 Maximum Continuous Drain Current vs Case Temperature

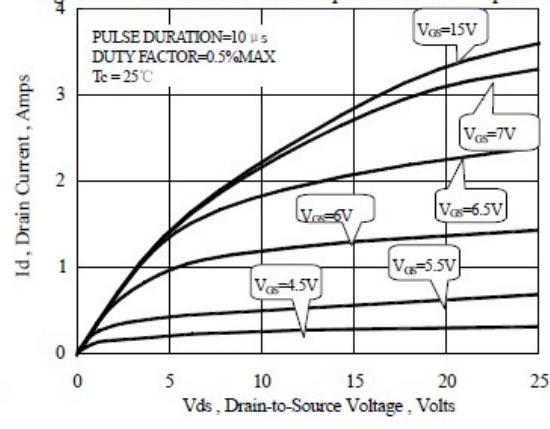


Figure 4 Typical Output Characteristics

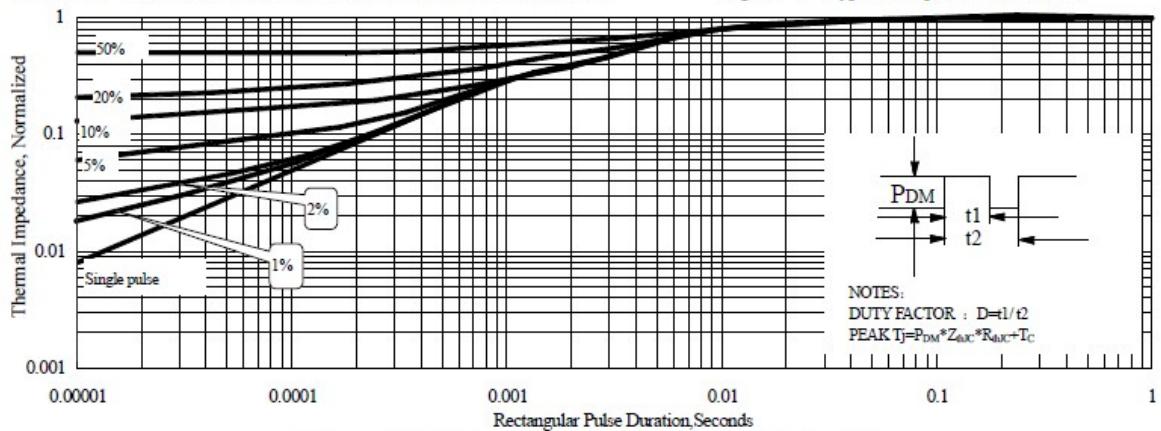


Figure 5 Maximum Effective Thermal Impedance, Junction to Case

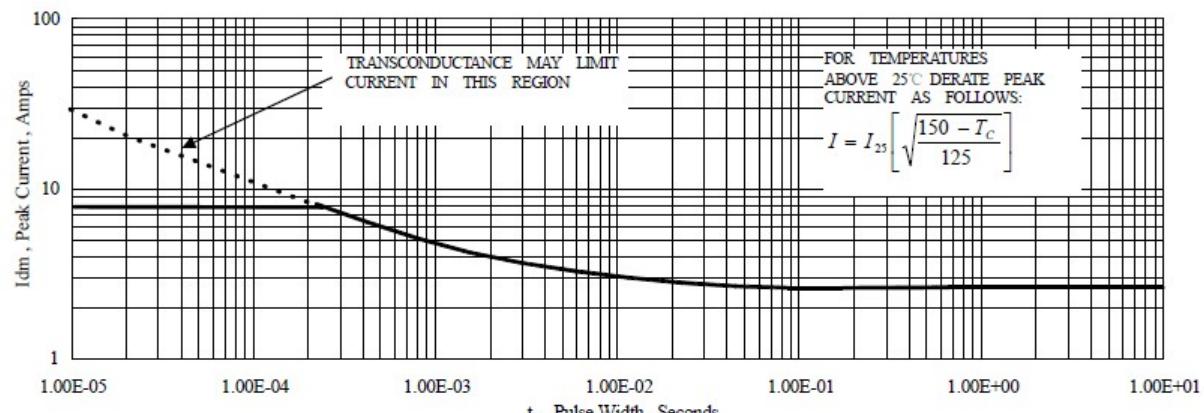


Figure 6 Maximum Peak Current Capability

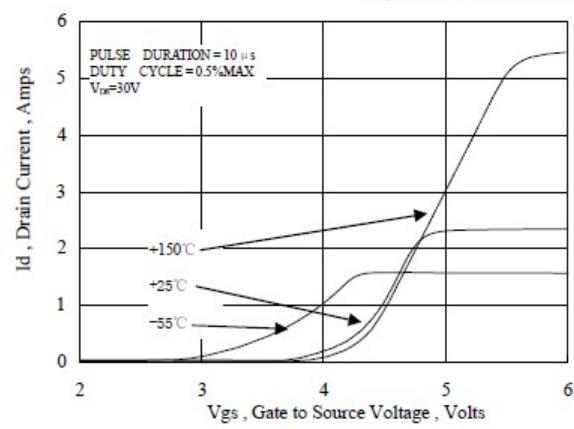


Figure 7 Typical Transfer Characteristics

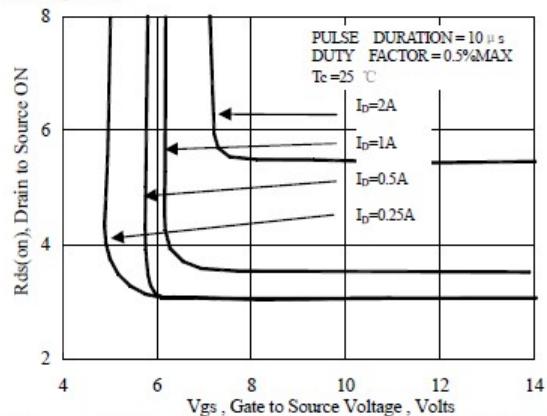


Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

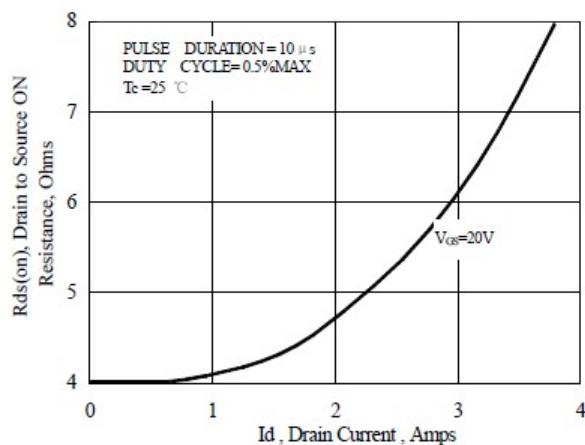


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

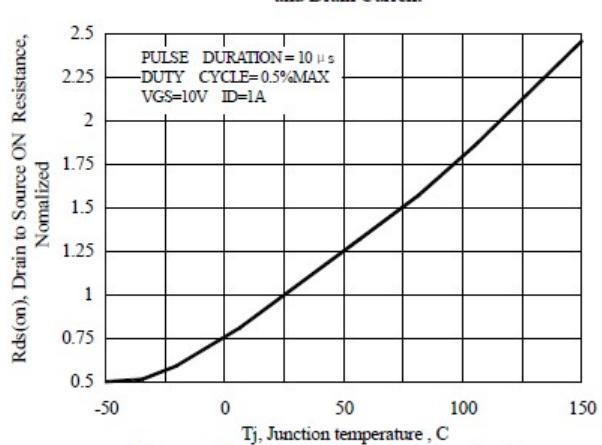


Figure 10 Typical Drian to Source on Resistance vs Junction Temperature

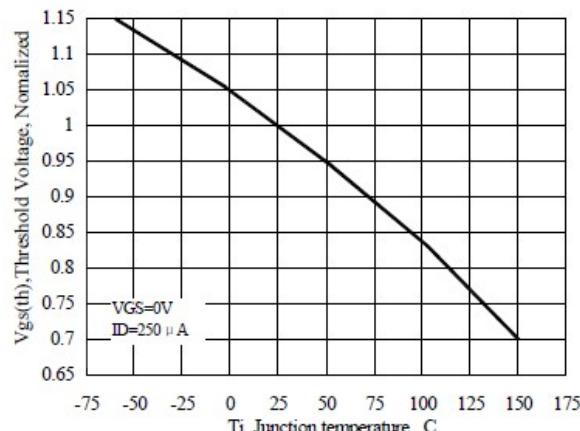


Figure 11 Typical Threshold Voltage vs Junction Temperature

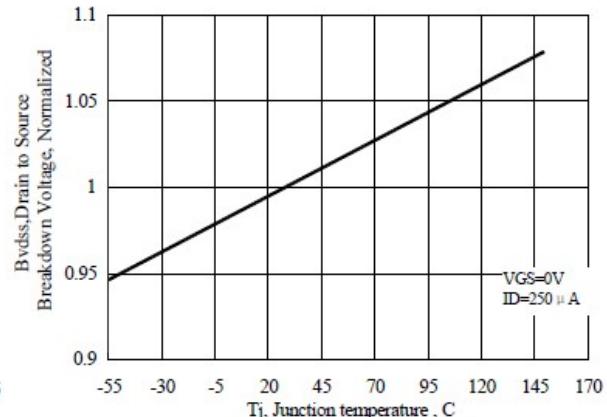


Figure 12 Typical Breakdown Voltage vs Junction Temperature

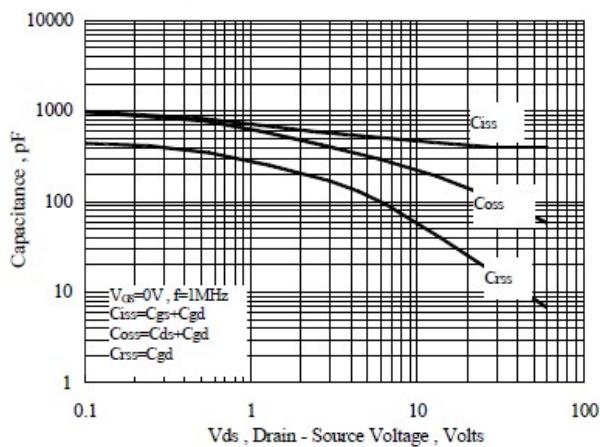


Figure 13 Typical Capacitance vs Drain to Source Voltage

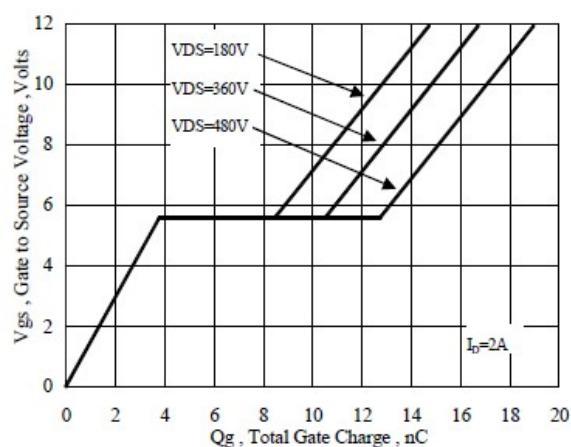


Figure 14 Typical Gate Charge vs Gate to Source Voltage

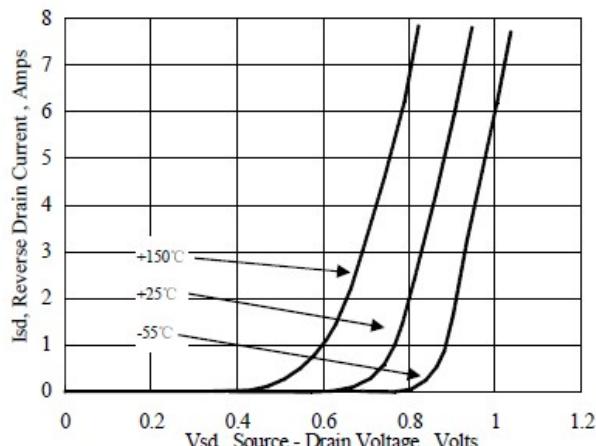


Figure 15 Typical Body Diode Transfer Characteristics

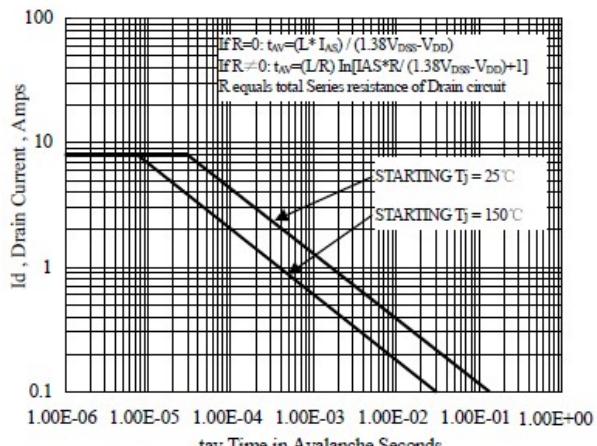


Figure 16 Unclamped Inductive Switching Capability

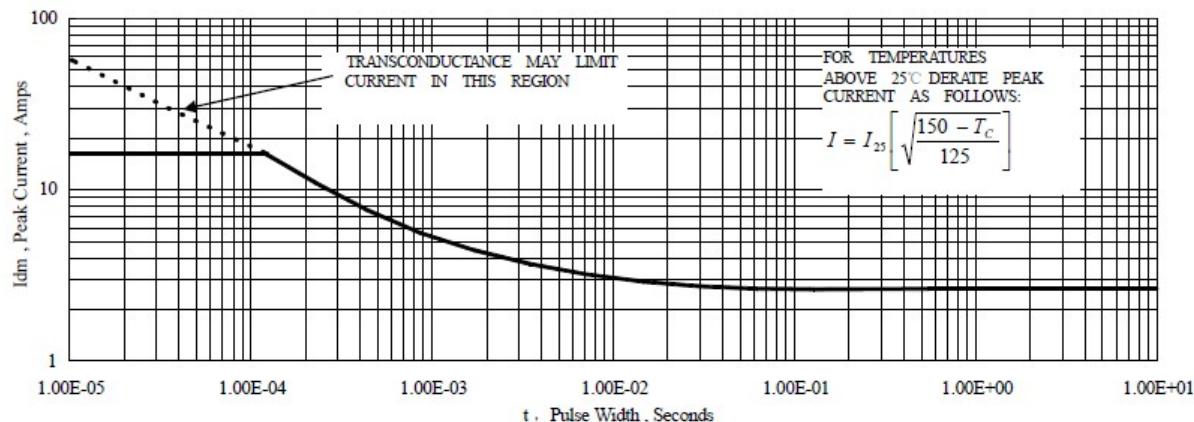


Figure 6 Maximum Peak Current Capability

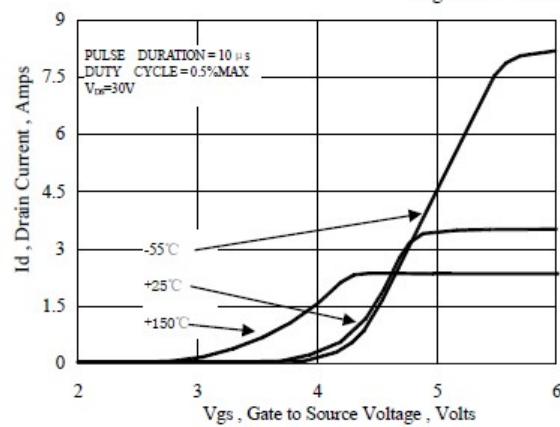


Figure 7 Typical Transfer Characteristics

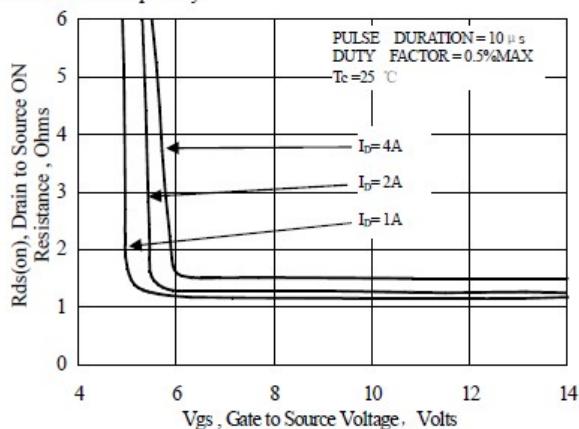


Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

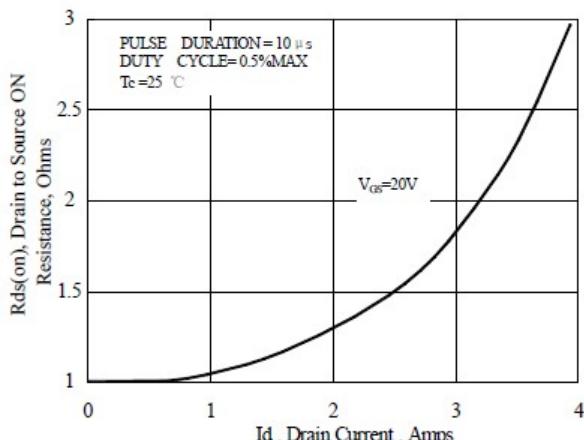


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

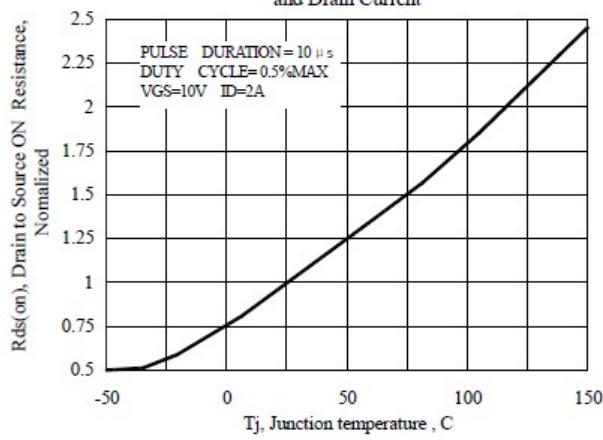


Figure 10 Typical Drain to Source on Resistance vs Junction Temperature